

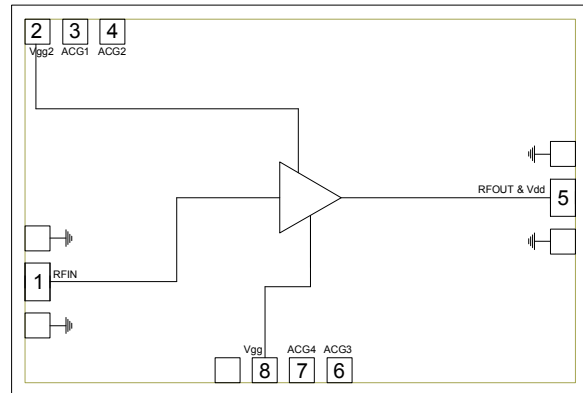
Features

- ▶ Ultra wideband performance
- ▶ Low current consumption
- ▶ Excellent return losses
- ▶ Small die size

Description

The CMD242 is wideband GaAs MMIC distributed low noise amplifier die which operates from DC to 40 GHz. The amplifier delivers greater than 10.5 dB of gain with a corresponding noise figure of 4.4 dB and output 1 dB compression point of 18.0 dBm at 20 GHz. The CMD242 is a 50 ohm matched design which eliminates the need for RF port matching. The CMD242 offers full passivation for increased reliability and moisture protection.

Functional Block Diagram



Note: Vgg2 is optional for gain control

Electrical Performance - $V_{dd} = 8.0\text{ V}$, $V_{gg} = -0.32\text{ V}$, $T_A = 25\text{ }^\circ\text{C}$, $F = 20\text{ GHz}$

Parameter	Min	Typ	Max	Units
Frequency Range	DC - 40			GHz
Gain		11		dB
Noise Figure		4.4		dB
Input Return Loss		18		dB
Output Return Loss		18		dB
Output P1dB		18		dBm
Output IP3		27		dBm
Supply Current		100		mA

Specifications

Absolute Maximum Ratings

Parameter	Rating
Drain Voltage, V _{dd}	10 V
Gate Voltage, V _{gg}	-2.5 to 0 V
RF Input Power	+23 dBm
Channel Temperature, T _{ch}	150 °C
Power Dissipation, P _{diss}	1.05 W
Thermal Resistance, Θ_{JC}	62.1 °C/W
Operating Temperature	-55 to 85 °C
Storage Temperature	-55 to 150 °C

Exceeding any one or combination of the maximum ratings may cause permanent damage to the device.

Recommended Operating Conditions

Parameter	Min	Typ	Max	Units
V _{dd}	5.0	8.0	8.5	V
I _{dd}		100		mA
V _{gg}		-0.32		V

Electrical performance is measured at specific test conditions. Electrical specifications are not guaranteed over all recommended operating conditions.

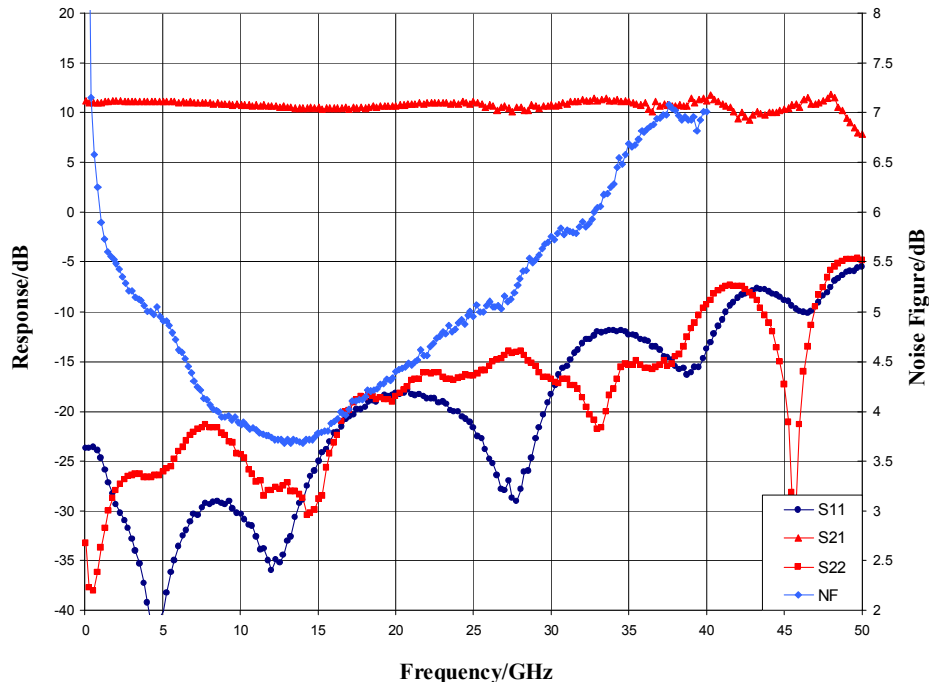
Electrical Specifications, V_{dd} = 8.0 V, V_{gg} = -0.32 V, T_A = 25 °C

Parameter	Min	Typ	Max	Min	Typ	Max	Units
Frequency Range	DC - 20		20 - 40				GHz
Gain	7	10.5		7.5	10.5		dB
Noise Figure		4.5			6		dB
Input Return Loss		25			15		dB
Output Return Loss		22			13		dB
Output P1dB	14.5	17.5		15	19		dBm
Output IP3		28			26		dBm
Supply Current	70	100	130	70	100	130	mA
Gain Temperature Coefficient		0.015			0.02		dB/°C
Noise Figure Temperature Coefficient		0.02			0.025		dB/°C

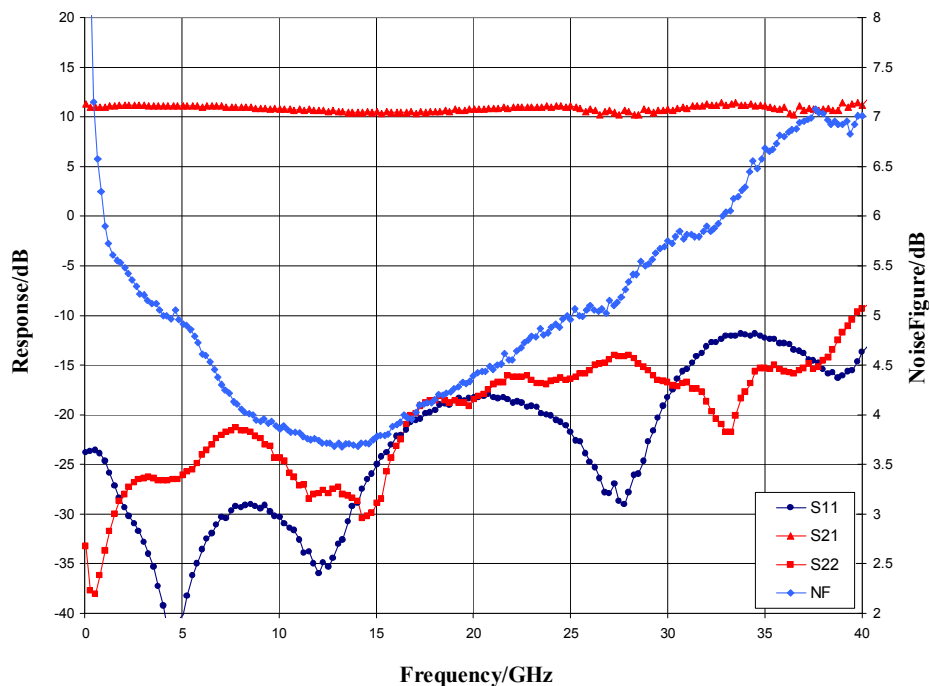
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Typical Performance

Broadband Performance, $V_{dd} = 8\text{ V}$, $V_{gg} = -0.32\text{ V}$, $I_{dd} = 100\text{ mA}$, $T_A = 25\text{ }^\circ\text{C}$



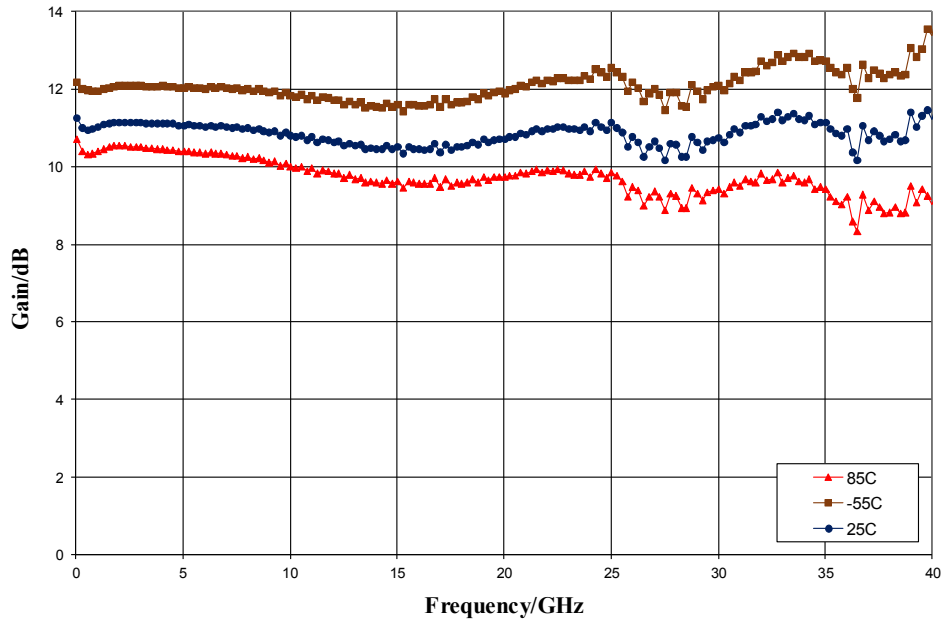
Narrow-band Performance, $V_{dd} = 8\text{ V}$, $V_{gg} = -0.32\text{ V}$, $I_{dd} = 100\text{ mA}$, $T_A = 25\text{ }^\circ\text{C}$



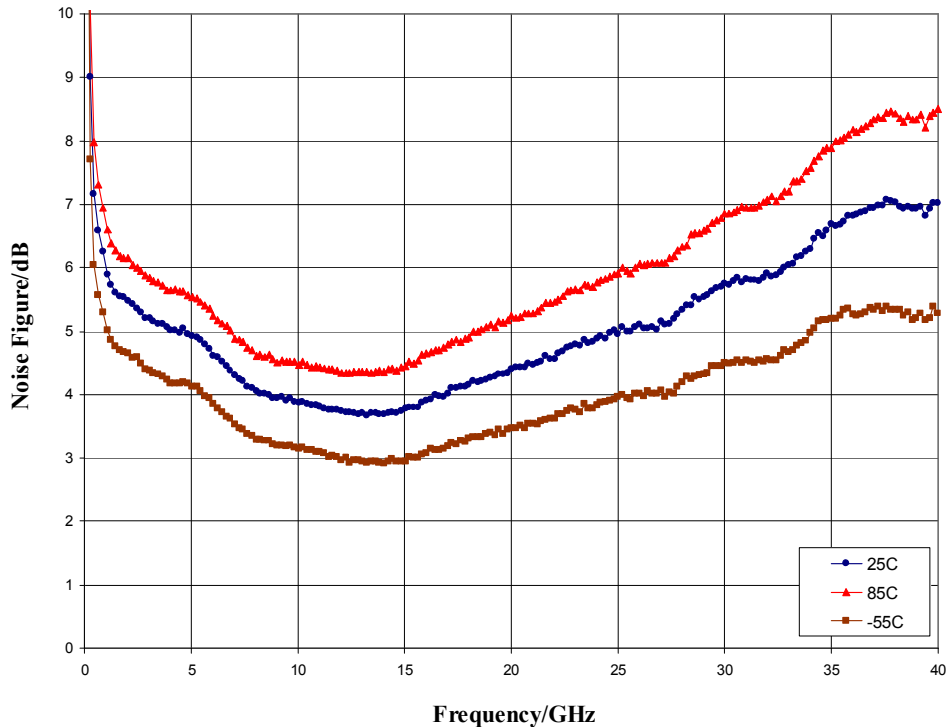
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Typical Performance

Gain vs. Temperature, $V_{dd} = 8\text{ V}$, $V_{gg} = -0.32\text{ V}$



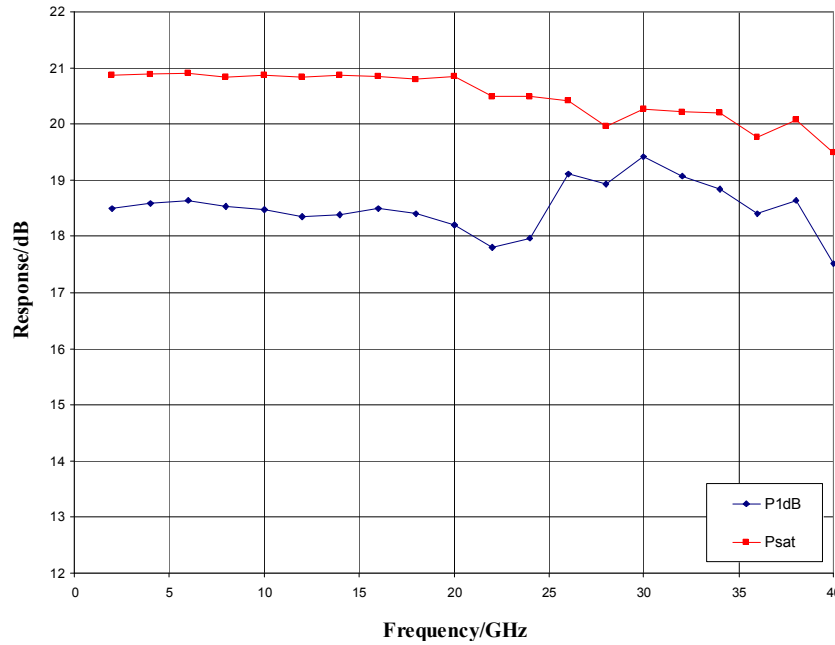
Noise Figure vs. Temperature, $V_{dd} = 8\text{ V}$, $V_{gg} = -0.32\text{ V}$



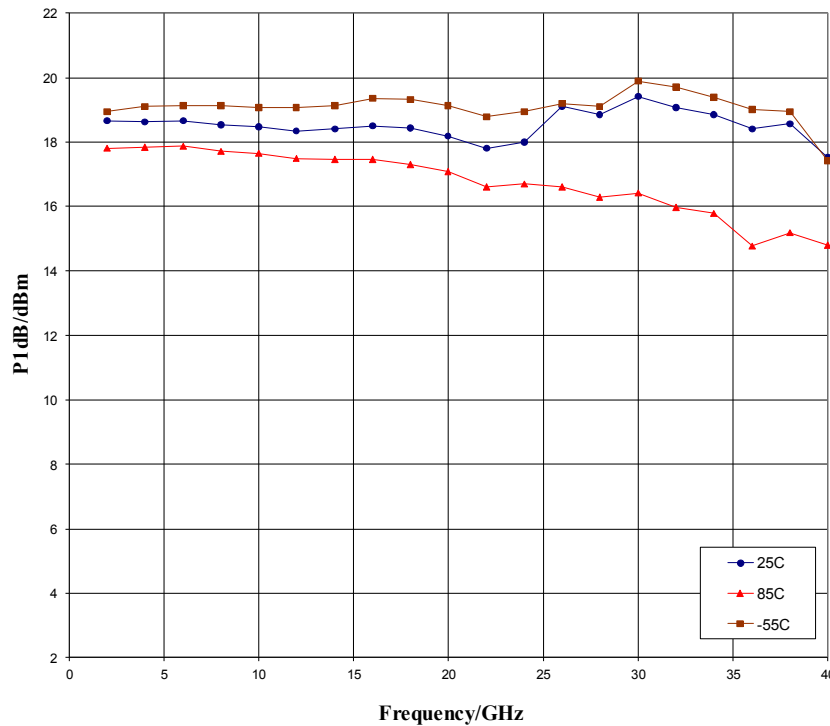
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Typical Performance

Output Power, $V_{dd} = 8V$, $V_{gg} = -0.32V$, $T_A = 25^\circ C$



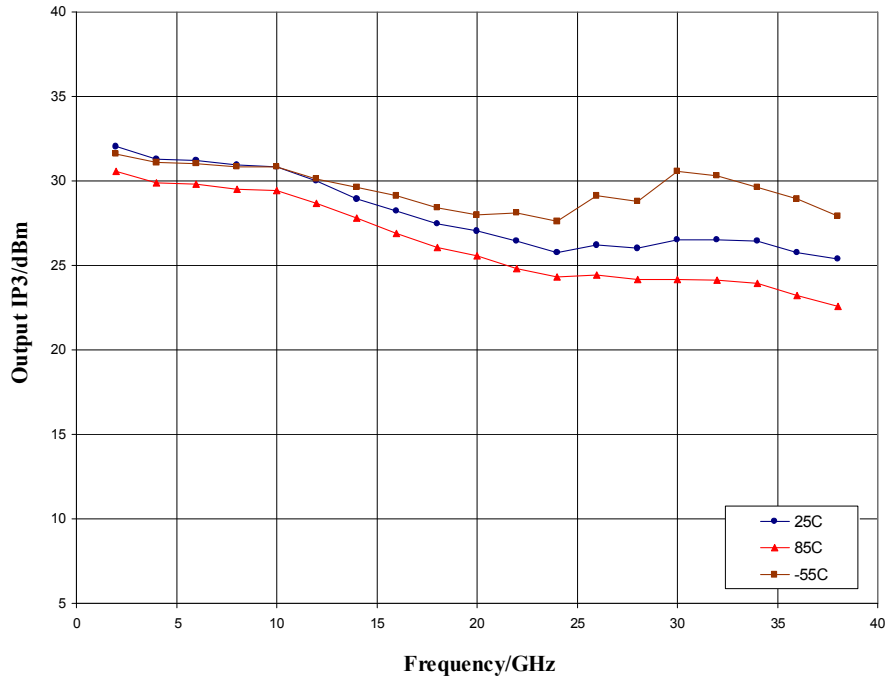
P1dB vs. Temperature, $V_{dd} = 8V$, $V_{gg} = -0.32V$



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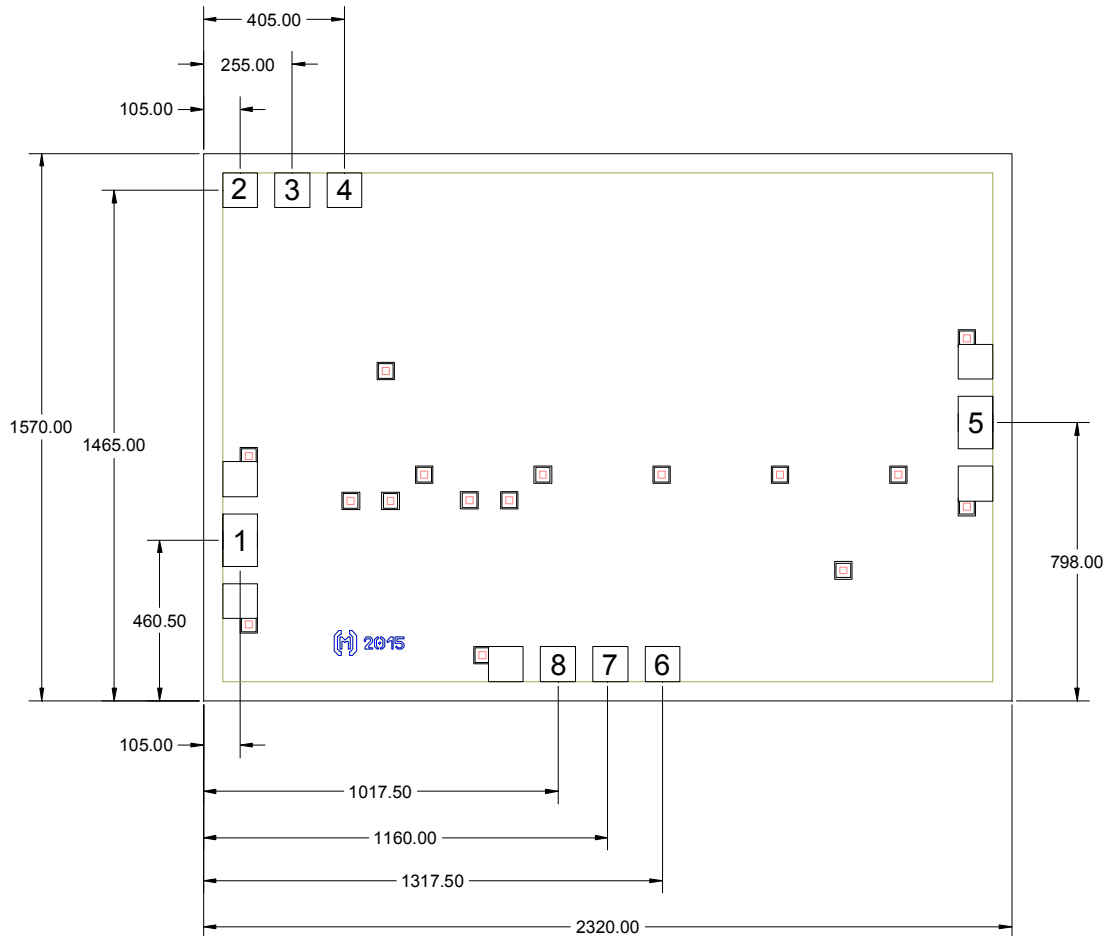
Typical Performance

Output IP3 vs. Temperature, $V_{dd} = 8\text{ V}$, $V_{gg} = -0.32\text{ V}$



Mechanical Information

Die Outline (all dimensions in microns)

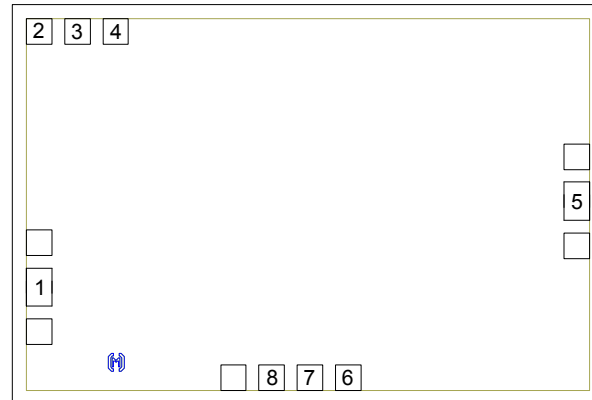


Notes:

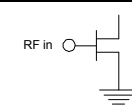
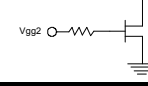
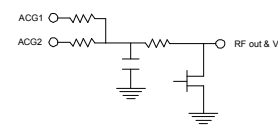
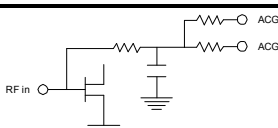
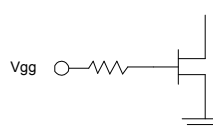

1. No connection required for unlabeled pads
2. Backside is RF and DC ground
3. Backside and bond pad metal: Gold
4. Die is 70 microns thick
5. DC bond pads (2, 3, 4, 6, 7, 8) are 100 x 100 microns
6. RF bond pads (1, 5) are 100 x 150 microns

Pad Description

Pad Diagram



Functional Description

Pad	Function	Description	Schematic
1	RF in	50 ohm matched input	
2	V _{gg2}	Optional supply voltage for gain control Decoupling and bypass caps required	
3, 4	ACG1, 2	Low frequency termination. Attach bypass capacitor per application circuit	
5	RF out & V _{dd}	Power supply voltage and 50 ohm matched output	
6, 7	ACG3, 4	Low frequency termination. Attach bypass capacitor per application circuit	
8	V _{gg}	Power supply voltage Decoupling and bypass caps required	
Backside	Ground	Connect to RF / DC ground	

Applications Information

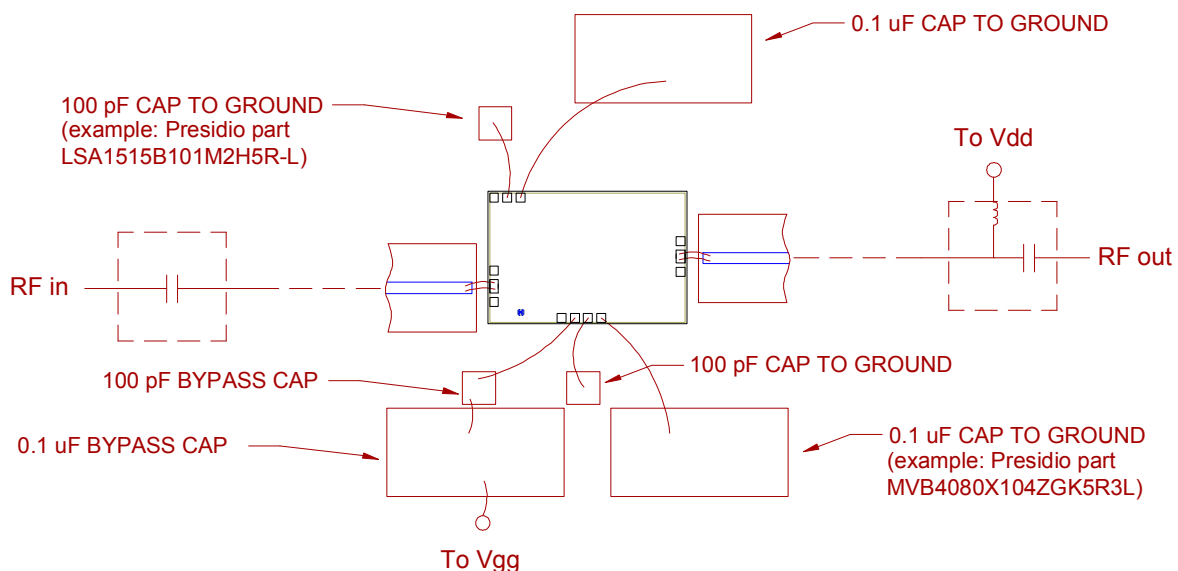
Assembly Guidelines

The backside of the CMD242 is RF ground. Die attach should be accomplished with electrically and thermally conductive epoxy or eutectic attach. Standard assembly procedures should be followed for high frequency devices. The top surface of the semiconductor should be made planar to the adjacent RF transmission lines, and the RF decoupling capacitors placed in close proximity to the DC connections on chip.

RF connections should be made as short as possible to reduce the inductive effect of the bond wire. Use of a 0.8 mil thermosonic wedge bonding is highly recommended as the loop height will be minimized. The RF input and output require a double bond wire as shown.

The semiconductor is 70 um thick and should be handled by the sides of the die or with a custom collet. Do not make contact directly with the die surface as this will damage the monolithic circuitry. Handle with care.

Assembly Diagram



GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.